## nexperia

## **Quarterly Reliability Monitoring Results**

Quarters: Q1/2021 to Q4/2021

Based on structural similarity
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Supplier		User Part Number					
Nexperia B.V.		PMEG3005ELD					
Name of Laboratory		Part Description					
		Nexperia DHAM	Schottky				
Assembly reliability labs		MCD package					
Based on AEC-Q101 Test		Test Conditions	Duration	# Lots	# Quantity	# Rejects	
	TEST						
	Pre- and Post-Stress						
# E1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below	
		JESD22-A113					
	PC	Bake Tamb = 125 °C	24 hours				
	PC Preconditioning	Soak Tamb = 85 °C, RH = 85% Reflow soldering	168 hours 3 cycles		0040		
# A1	Preconationing		5 Cycles	113	9040	0	
		MIL-STD-750-1 M1038 Method A					
	HTRB High Temperature Reverse	Tj = Tjmax, Vr = $100\%$ of max. datasheet					
# B1	Bias	reverse voltage <sup>[1]</sup>	1000 hours	116	9280	0	
# BI	bids	Teverse voltage	1000 110015	110	9280	0	
	тс	JESD22-A104					
# A4	Temperature Cycling	-65 °C to Tjmax, not to exceed 150°C	1000 cycles	28	2240	0	
		JESD22-A102					
	AC	Tamb = $121 ^{\circ}C$ , RH = $100 ^{\circ}M$					
# A3 alt	Autoclave	Pressure = 205 kPa (29.7 psia)	96 hours	28	2240	0	
	H3TRB	JESD22-A101					
	High Humidity High	Tamb = 85 °C, RH = 85%, VR = 80 % of					
# A2 alt	Temperature Reverse Bias	rated reverse voltage <sup>[1], [2]</sup>	1000 hours	28	2240	0	
		MIL-STD-750 Method 1037					
	IOL	ton = toff, devices powered to insure $\Delta Tj$ =					
# A5	Intermittent Operating Life	100 °C for 15000 cycles	1000 hours	29	2320	0	
	RSH	JESD22-A111					
# C8	Resistance to Solder Heat	260 °C ± 5 °C	10 s	n.a.	n.a.	n.a.	
	SD						
# C10	Solderability	J-STD-002		63	630	0	

[1] The physical limitations of Schottky diodes have to be considered (thermal runaway).

[2] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## **Calculation of FIT and MTTF**

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Nexperia	F (hrs)
DHAM Schottky 9280 0 0.46 2.19	E+09

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